

IMS 2 Evaluation Platform

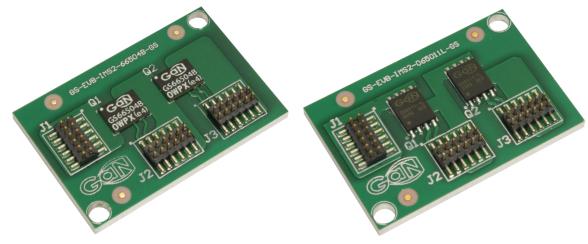
Technical Manual

GS-EVB-IMS2-LPMB

GS-EVB-IMS2-065011L-GS

GS-EVB-IMS2-66504B-GS







Visit www.gansystems.com for the latest version of this technical manual



DANGER



DO NOT TOUCH THE BOARD WHEN IT IS ENERGIZED AND ALLOW ALL COMPONENTS TO DISCHARGE COMPLETELY PRIOR HANDLING THE BOARD.

HIGH VOLTAGE CAN BE EXPOSED ON THE BOARD WHEN IT IS CONNECTED TO POWER SOURCE. EVEN BRIEF CONTACT DURING OPERATION MAY RESULT IN SEVERE INJURY OR DEATH.

Please sure that appropriate safety procedures are followed. This evaluation kit is designed for **engineering evaluation in a controlled lab environment and should be handled by qualified personnel ONLY**. Never leave the board operating unattended.



WARNING

Some components can be hot during and after operation. There are NO built-in electrical or thermal protection on this evaluation kit. The operating voltage, current and component temperature should be monitored closely during operation to prevent device damage.



CAUTION

This product contains parts that are susceptible to damage by electrostatic discharge (ESD). Always follow ESD prevention procedures when handling the product.



GS-EVB-IMS2-XX Low Power IMS 2 Evaluation Platform Technical Manual

Contents

L	Ove	rview	5
	1.1	Introduction	5
	1.2	IMS 2 Evaluation Platform Overview	<i>6</i>
	1.2.1	Technical Description	<i>6</i>
	1.2.2	2 IMS Board thermal design	
	1.3	IMS 2 Half Bridge Board Design	9
	1.4	IMS 2 EVB Mother Board	10
	1.4.1	Gate Driver Circuit	11
	1.4.2	2 15V input	11
	1.4.3	3 Temperature monitoring holes	12
	1.4.4		
	1.4.5	Installation of IMS 2 Half Bridge Power Board	12
	1.4.6	5 DC link decoupling capacitors	12
	1.4.7		
2	Test	Results	14
	2.1	Double pulse test (GS-EVB-IMS2-LPMB+ GS-EVB-IMS2-065011L-GS)	14
	2.2	Full power emulation test (GS-EVB-IMS2-LPMB + GS-EVB-IMS2-065011L-GS)	15
3	App	endix	17
	3.1	IMS 2 Half Bridge Power Board	
	3.2	IMS 2 FVB Mother board, GS-FVB-IMS2-I PMB	10





List of Figures

Figure 1 IMS 2 EVB board and IMS 2 half bridge power module with heatsink	5
Figure 2 - GS-065-011-1-L PDFN and GS66504B GaNPX® packaged E-HEMTs	6
Figure 3 Cross-section view of a single layer IMS board	
Figure 4 Comparison of Junction to Heatsink thermal resistance (RthJ-Hs) (Estimated based on GS665	16B) . 8
Figure 5 IMS 2 half bridge power board (GS-EVB-IMS2-065011L-GS)	9
Figure 6 Circuit block diagram of IMS 2 EVB board	10
Figure 7 GS-EVB-IMS2-LPMB	10
Figure 8 Gate driver circuit	11
Figure 9 External PWM signals connector	12
Figure 10 - Cross section view of IMS assembly showing the power Loop path	12
Figure 11 Double pulse test setup	14
Figure 12 Double pulse test waveforms (400V/13A)	14
List of Tables	
Table 1 Ordering configuration and part numbers	6
Table 2 Part numbers and Description	e
Table 3 Performance comparison of 3 thermal design options for SMT power devices	8



1 Overview

1.1 Introduction

A frequent challenge for power designers is to engineer a product that has excellent power density and reduced cost of the system simultaneously.

This IMS evaluation platform demonstrates an effective way to improve heat transfer, to increase power density and reduce system cost. An Insulated Metal Substrate PCB (IMS PCB) is used to cool GaN Systems' bottom-side cooled power transistors. An IMS PCB is also known as Metal Core/Aluminum PCB.

Examples of applications that have successfully used this approach include:

• Automotive: Wireless power charger

• Industrial: Photovoltaic Inverter and Appliance Motor Drive / VFD

• **Server/Datacenter:** Server AC/DC power supply

• Consumer: High Power Adapters, Residential Energy Storage System (ESS)

This evaluation platform consists of two parts: the IMS 2 EVB board (mother board) and the IMS 2 half bridge power board, as show in Figure 1. The IMS 2 half bridge power board is available in 2 power levels: 300W and 500W.



Heatsink is not included for lower power applications. However, for higher power applications, cusotmized heatsink may be required. To prevent device damage, ensure adequate heatsinking through design and by monitoring the component temperatures during operation.



To assemble a heatsink, apply thermal grease to the heatsink / IMS board interface before screwing the units together. Enough thermal grease should be applied so that a small amount extrudes on all four sizes as the screws are tightened. Wipe the assembly clean.



Figure 1 IMS 2 EVB mother board and IMS 2 half bridge power module

With these building blocks, the evaluation platform can be purchased in 4 different configurations: 300W and 500W, half bridge and full bridge. Table 1 lists the ordering options.



500W Full Bridge

CONFIGURATION	IMS 2 HALF BRIDGE MODULE	IMS 2 EVB Mother Board
300W Half Bridge	QTY 1 - GS-EVB-IMS2-065011L-GS	
500W Half Bridge	QTY 1 - GS-EVB-IMS2-66504B-GS	GS-EVB-IMS2-LPMB
300W Full Bridge	OTY 2 - GS-EVB-IMS2-065011L-GS	G5-E V D-IIVI52-LF IVID

Table 1 Ordering configuration and part numbers

Table 2 Part numbers and Description

OTY 2 - GS-EVB-IMS2-66504B-GS

PART NUMBER	DESCRIPTION	GaN E-HEMT	
	Optimized Dual HB Non-Isolated Gate Driver		
GS-EVB-IMS2-LPMB	Motherboard for use with GS-EVB-IMS2-065011L-GS	N/A	
	or GS-EVB-IMS2-66504B-GS half bridge boards		
GS-EVB-IMS2-065011L-GS	IMS2 Half Bridge Power Module with bottom-cooled		
G5-E V D-11V132-003011L-G3	GS-065-011-1-L PDFN for low power applications	GS-065-011-1-L	
CC EVID IMC2 ((E04D, CC	IMS2 Half Bridge Power Module with bottom-cooled	CCCCE04P	
GS-EVB-IMS2-66504B-GS	GS66504B GaNPX® for low power applications	GS66504B	

1.2 IMS 2 Evaluation Platform Overview

1.2.1 Technical Description

Using this platform, power designers can evaluate the performance of GaN Systems' E-HEMTs (Enhancement mode High Electron Mobility Transistors) in low power, high efficiency applications. The IMS 2 half bridge power board is populated with GaN Systems' GS-065-011-1-L (bottom-side cooled E-HEMT, rated at 650 V / 150 m Ω) or GS66504B (bottom-side cooled E-HEMT, rated at 650 V /100 m Ω). This product has the following features:

- Large power source/thermal pad for improved thermal dissipation.
- Bottom-side cooled packaging for conventional PCB or advanced IMS/Cu inlay thermal design.
- Ultra-low inductance for high frequency switching.

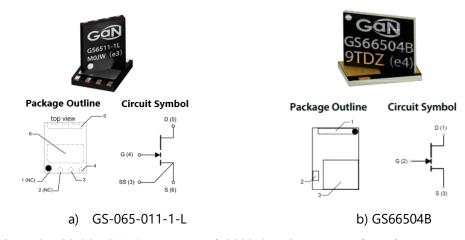


Figure 2 - GS-065-011-1-L PDFN and GS66504B GaNPX® packaged E-HEMTs



The IMS 2 half bridge power board is designed for users to gain hands-on experience in the following ways:

- Evaluate the GaN E-HEMT performance in any half bridge based topology, over a range of operating conditions. This can be done using either the accompanying power motherboard (P/N: GS-EVB-IMS2-LPMB) or with the users' own board for in-system prototyping.
- Use as a thermal and electrical design reference of the GS-065-011-1-L PDFN or GS66504B GaNPX® package in demanding high power density and high efficiency applications.

1.2.2 IMS Board thermal design

An IMS board assembly uses metal as the PCB core, to which a dielectric layer and copper foil layers are bonded. The metal PCB core is often aluminum. The copper foil layers can be single or double-sided. An IMS board offers superior thermal conductivity to standard FR4 PCB. It's commonly used in high power, high current applications where most of heat is concentrated in a small footprint SMT device.

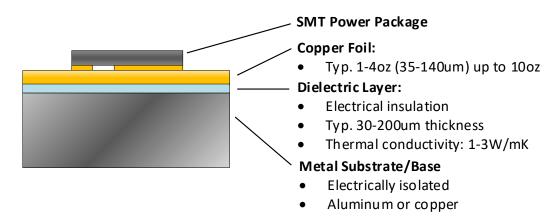


Figure 3 Cross-section view of a single layer IMS board

As high-speed Gallium Nitride power devices are adopted widely, the industry is trending away from through-hole packaging (TH), towards surface mount packaging (SMT). Traditional TH devices, such as the TO-220, are no longer the appropriate choice because their high parasitic inductance and capacitance negate the performance benefits offered by GaN E-HEMTs. SMT packaging, such as PQFN, D2PAK and GaN Systems' GaNPX®, by comparison, offer low inductance and low thermal impedance, enabling efficient designs at high power and high switching frequency.

Thermal management of SMT power transistors must be approached differently than TH devices. TO packages are cooled by attaching them to a heatsink, with an intermediary Thermal Interface material (TIM) sheet for electrical high voltage insulation. The traditional cooling method for SMT power devices is to use thermal vias tied to multiple copper layers in a PCB. The IMS board presents designers with another option which is especially useful for high power applications. The IMS board has a much lower junction to heatsink thermal resistance (R_{thJ-HS}) than FR4 PCBs, for efficient heat transfer out of the transistor. As well, assembly on an IMS board has lower assembly cost and risk than the TH alternative. The manual assembly process of a TO package onto a heatsink is costly and prone to human error.

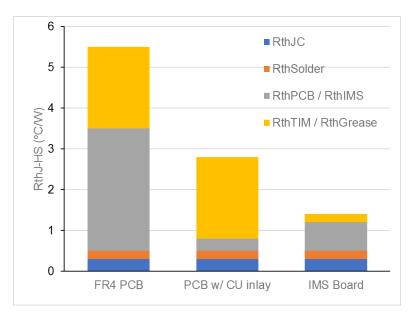
the metal substrate



Table 3 compares 3 different design approaches for cooling discrete SMT power devices. While the cost is lower for a FR4 PCB cooling with thermal vias, the IMS board offers the best performance for thermal management. Figure 4 provides a quantitative comparison of the thermal resistance for the 3 design options using GS66516T as an example. The IMS board clearly comes out ahead.

FR4 PCB Cooling with Vias FR4 PCB with Cu inlay **IMS PCB** Board The rm al gre ase **Thermal** Good **Better Best** resistance **Electrical** No, additional TIM No, additional TIM needed Yes Insulation needed Cost Lowest High Low Layout flexibility Standard process Lowest thermal resistance • Improved thermal **Advantages** Lowest cost Electrically isolated compared to thermal vias Layout flexibility • Layout limited to 1 layer Cu-inlay surface Design High PCB thermal coplanarity Parasitic inductance High TIM thermal challenges resistance Coupling capacitances to

Table 3 Performance comparison of 3 thermal design options for SMT power devices



resistance

Figure 4 Comparison of Junction to Heatsink thermal resistance (R_{thJ-HS}) (Estimated based on GS66516B as an example)



The following additional measures are taken to optimize the design further.

- The IMS 2 evaluation platform is implemented as a two-board asssembly. The gate drive circuitry is assembled on the GS-EVB-IMS2-LPMB, a multi-layer FR4 PCB mother board. This includes the high-speed half-bridge drivers for GaN power switches and DC decoupling capacitors. The GaN E-HEMTs are mounted to the IMS half bridge board (GS-EVB-IMS2-065011L-GS and GS-EVB-IMS2-66504B-GS). This approach addresses the shortcomings of implementing the design on a single layer IMS board.
- While a large copper area is preferred to maximize heat spreading and handle high current, the
 area of copper at the switching node (high dv/dt) needs to be minimized to reduce the parasitic
 coupling capacitance to the metal substrate. An IMS board with thicker dielectric layer (100um) is
 chosen on this design to further reduce this effect.

1.3 IMS 2 Half Bridge Board Design

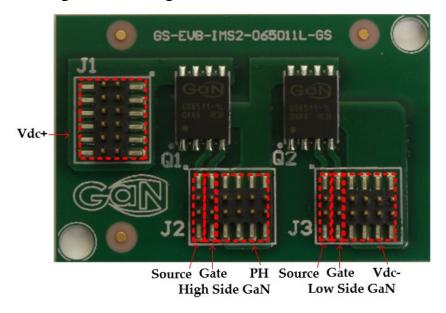


Figure 5 IMS 2 half bridge power board (GS-EVB-IMS2-065011L-GS)

The IMS 2 half bridge power board is populated with the following components:

- Q1 and Q2: GS-065-011-1-L or GS66504B E-HEMTs in a half bridge configuration.
 - o 300W GS-EVB-IMS2-065011L-GS: Q1/Q2 GS-065-011-1-L.
 - o 500W GS-EVB-IMS2-66504B-GS: Q1/Q2 GS66504B.
- J1, J2, J3:
 - Connector Header Surface Mount 12 position 0.050" (1.27mm) (Samtec Inc., P/N: FTS-106-02-F-DV).
 - o These terminals are designed to carry the main current and gate signals.



1.4 IMS 2 EVB Mother Board

GaN Systems offers a low-power IMS 2 evaluation board that can be purchased separately. The ordering part number is GS-EVB-IMS2-LPMB. It can be used as a platform for evaluating the IMS board in any half or full bridge topology.

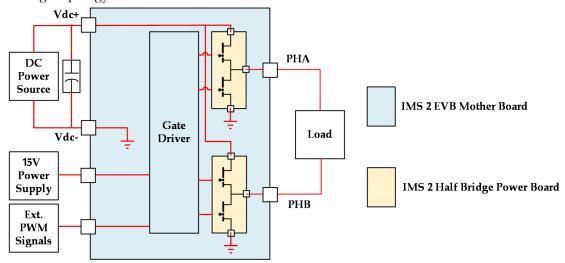


Figure 6 Circuit block diagram of IMS 2 EVB board

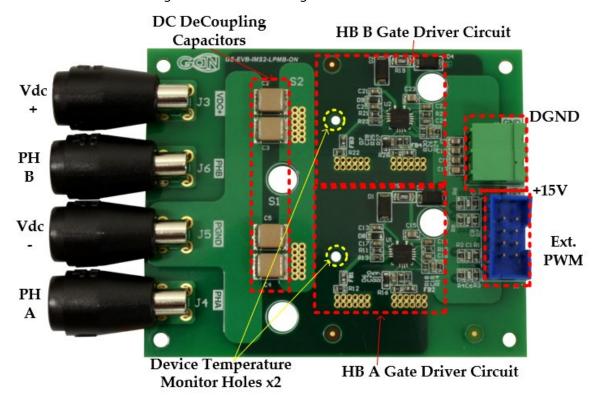


Figure 7 GS-EVB-IMS2-LPMB



1.4.1 Gate Driver Circuit

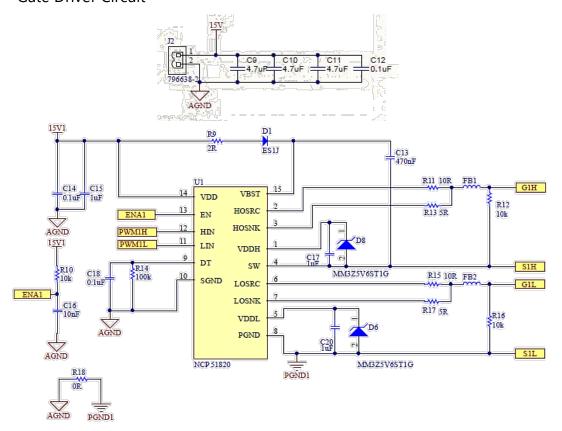


Figure 8 Gate driver circuit

A low-cost half-bridge gate driver is used in the IMS 2 EVB board for GaN half bridge, which is shown in Figure 8:

- U1 is the half-bridge gate driver (ON Semiconductor P/N: NCP51820). It outputs +6V/0V gate-driving signal.
- o R11 and R13 are gate turn-on and off resistors for high-side GaN E-HEMT, R15 and R17 are for low-side GaN E-HEMT.
- o FB1 FB2 are ferrit beads for filtering the gate signal noise.
- o D6 and D8 are to protect E-HEMT gate from over-voltage.
- o The peripheral circuit refers to the NCP51820 half bridge example in its datasheet (for more information: https://www.onsemi.com/pub/Collateral/NCP51820-D.PDF)

1.4.2 15V input

The gate driver circuit on the IMS 2 EVB mother board is powered from a 15V DC source, through connector J2.



1.4.3 Temperature monitoring holes

Two holes are located on the center of two high-side GaN E-HEMTs to assist with the temperature monitoring during operation. A thermal camera can be used to monitor the case temperature through these holes. The temperature measured at the center of package will be close to the T_J.



NOTE: Thermal performance of the transistors is dependent on a number of factors including circuit configuration, ambient temperature, airflow, and heatsinking. The user is responsible for monitoring the temperature of the devices to ensure operation remains within specification.

1.4.4 External PWM Signals Input

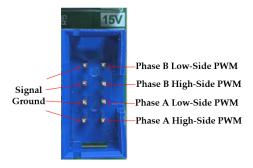


Figure 9 External PWM signals connector

The PWM signals of all four GaN devices come from the external PWM connector J1, as shown in Figure 9. The deadtime of PWM signals are required and should be provided from the external source.

1.4.5 Installation of IMS 2 Half Bridge Power Board

To achieve the lowest power loop parasitics, it is suggested to solder the IMS 2 half bridge power board to the IMS 2 EVB motherboard.

1.4.6 DC link decoupling capacitors

As it is challenging to create low inductance power loop on single-layer IMS board, DC decoupling capacitors are placed on multi-layer IMS 2 EVB PCB. The power loop path is highlighted as below.

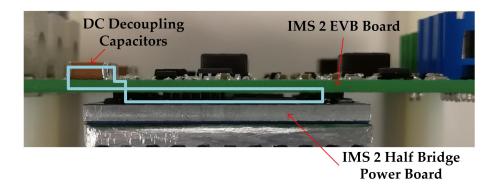


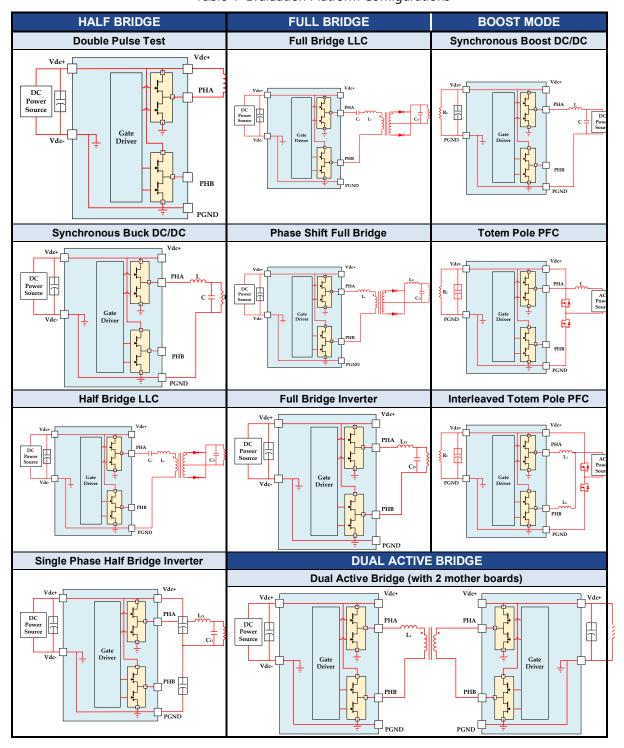
Figure 10 - Cross section view of IMS assembly showing the power Loop path



1.4.7 Operation modes

The Evaluation Platform can be configured into different topologies and operation modes as shown below

Table 4 Evaluation Platform Configurations





2 Test Results

2.1 Double pulse test (GS-EVB-IMS2-LPMB + GS-EVB-IMS2-065011L-GS)

- Test condition: V_{DC} = 400V, I_D = 13A, V_{CS} = +6V/0V, L = 81.6uH, No RC Snubber, T_J =25°C
- Measured peak $V_{DS} = 568V$ and 50.26V/ns peak dV/dt
- Reliable hard switching with GS-065-011-1-L is achieved at full rated current

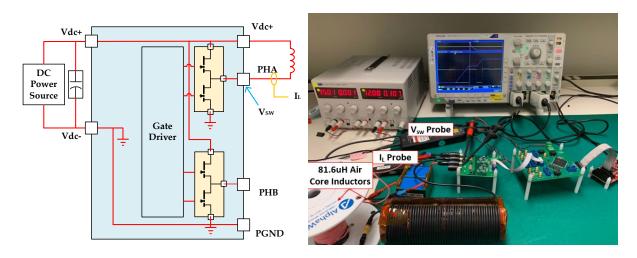


Figure 11 Double pulse test setup

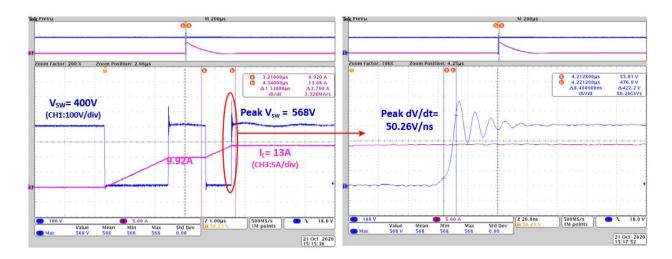


Figure 12 Double pulse test waveforms (400V/13A)



2.2 Full power emulation test (GS-EVB-IMS2-LPMB + GS-EVB-IMS2-065011L-GS)

- Test condition: $V_{DC} = 400V$, fsw=250kHz, Po=400W, $T_{AMB} = 25$ °C
- Device case temperature 30°C

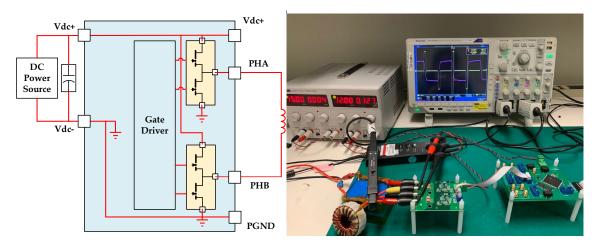


Figure 13 Full Power Emulation Test Setup

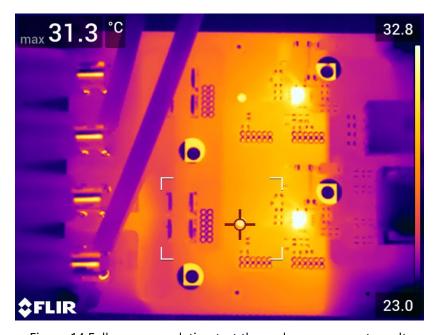
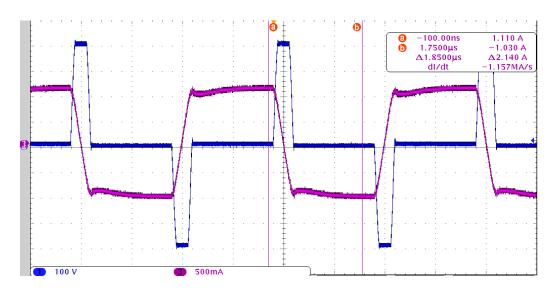


Figure 14 Full power emulation test thermal measurement result





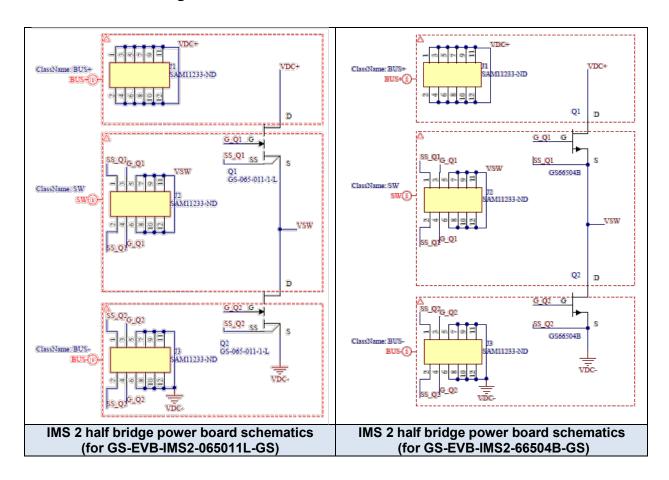
Ch#1 (blue): Switching node Voltage, 100V/div Ch#3 (purple): Inductor current, 0.5A/div

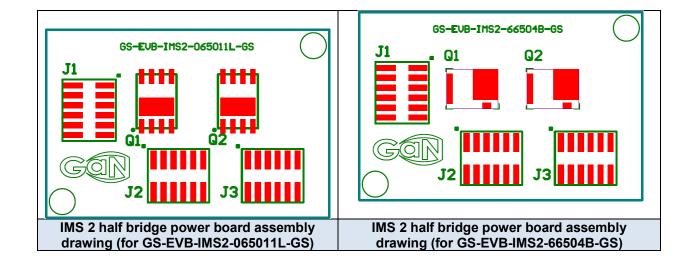
Figure 15 Test waveforms (400V_{DC}, 250kHz, Po=400W)



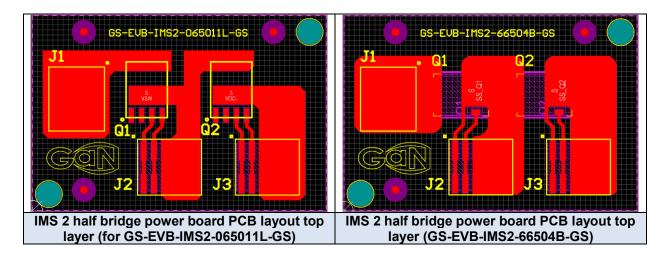
3 Appendix

3.1 IMS 2 Half Bridge Power Board







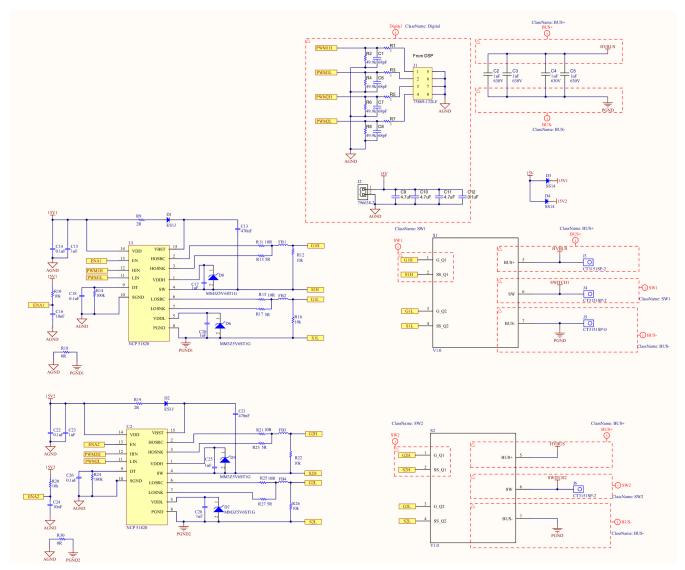


IMS 2 Half Bridge Power Board Bill of Materials (BOM)

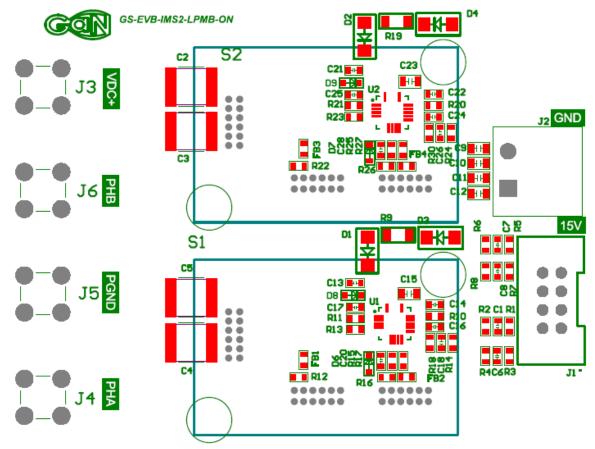
GS-EVB-IMS2-065011L-GS				
Comment	Description	Designator	Quantity	
	CONN HEADER SMD 12POS			
	1.27MM			
SAM11233-ND	FTS-106-02-F-DV	J1, J2, J3	3	
GS-065-011-1-L	GAN TRANS E-MODE 650V 11A	Q1, Q2	2	
GS-EVB-IMS2-66504B-GS				
Comment	Description	Designator	Quantity	
	CONN HEADER SMD 12POS			
	1.27MM			
SAM11233-ND	FTS-106-02-F-DV	J1, J2, J3	3	
GS66504B	GAN TRANS E-MODE 650V 15A	Q1, Q2	2	



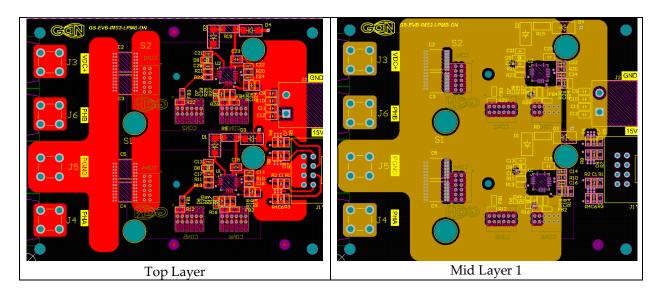
3.2 IMS 2 EVB Mother board - GS-EVB-IMS2-LPMB Schematics





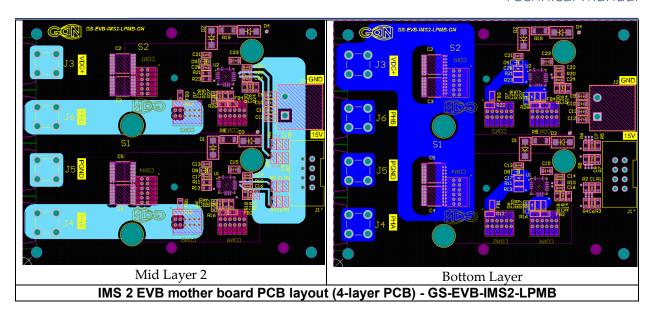


IMS 2 EVB mother board assembly drawing (top layer) - GS-EVB-IMS2-LPMB





GS-EVB-IMS2-XX Low Power IMS Evaluation Platform Technical Manual



IMS 2 EVB mother board Bill of Materials (BOM) - GS-EVB-IMS2-LPMB

Designator	Description	Quanti ty	Manufacture	Manufacture Part Number
C1, C6, C7, C8	CAP CER 68PF 50V C0G/NP0 0603	4	KEMET	C0603C680J5GACTU
C2, C3, C4, C5	CAP CER 1UF 630V X7R 2220	4	Knowles Syfer	2220Y6300105KXTWS2
C9, C10, C11	CAP CER 4.7UF 25V X7R 0805	3	Yageo	CC0805KKX5R8BB475
C12	CAP CER 0.1UF 25V X7R 0805	1	Yageo	CC0805KRX7R8BB104
C13, C21	CAP CER 470nF 25V X7R 0603	2	Yageo	CC0603KRX7R8BB474
C14, C18, C22, C26	CAP CER 100nF 25V X7R 0603	4	Yageo	CC0603KRX7R8BB104
C15, C23	CAP CER 1uF 25V X7R 0805	2	KEMET	C0805C105K3RACTU
C16, C24	CAP CER 10nF 25V X7R 0603	2	Yageo	CC0603KPX7R9BB103 CAP
C17, C20, C25, C28	CAP CER 1uF 25V X7R 0603	4	KEMET	C0603C105K3RACTU
D1, D2	600V 1A Schottky Barrier Diode	2	ON Semiconductor	ES1J
D3, D4	40V 1A Schottky Barrier Diode	2	ON Semiconductor	SS14
D6, D7, D8, D9	Zener Voltage Regulator, 300 mW, 2-Pin SOD-323, Pb-Free, Tape and Reel	4	ON Semiconductor	MM3Z5V6ST1G
FB1, FB2, FB3, FB4	FERRITE BEAD 120 OHM 0603 1LN	4	Murata Electronics	BLM18PG121SN1D
J1	CONN HEADER VERT 8POS 2.54MM	1	Amphenol ICC (FCI)	75869-132LF
J2	TERM BLOCK HDR 2POS 90DEG 5.08MM	1	TE Connectivity	796638-2
J3, J4, J6	Cal Test Electronics 'CT3151SP-2	3	Cal Test Electronics	CT3151SP-2
J5	Cal Test Electronics 'CT3151SP-0	1	Cal Test Electronics	CT3151SP-0
R1, R3, R5, R7	RES SMD 10HM 1% 1/10W 0603	4	Yageo	RC0603FR-071RL
R2, R4, R6, R8	RES SMD 49.9K OHM 1% 1/10W 0603	4	Yageo	RC0603FR-0749K9L
R9, R19	RES SMD 2 OHM 1% 1206	2	Yageo	RC1206JR-072RL
R10, R12, R16, R20, R22, R26	RES SMD 10k OHM 1% 1/10W 0603	6	Yageo	RC0603JR-0710KL
R11, R15, R21, R25	RES SMD 10 OHM 1% 1/10W 0603	4	Yageo	RC0603JR-0710RL
R13, R17, R23, R27	RES SMD 5 OHM 1% 1/10W 0603	4	Yageo	RC0603JR-075R1L



GS-EVB-IMS2-XX Low Power IMS Evaluation Platform Technical Manual

R14, R24	RES SMD 100k OHM 1% 1/10W 0603	2	Yageo	RC0603JR-07100KL
R18, R30	RES SMD 0 OHM 1% 1/10W 0603	2	Yageo	RC0603JR-070RL
CON1,CON2,C ON3,CON4,CO N5,CON6,	CLP-106-02-L-D-K-TR CONN RCPT 12POS 0.05 GOLD SMD	6	Samtec Inc.	SAM13405CT-ND
U1, U2	NCP51820AMNTWG	2	ON Semiconductor	NCP51820AMNTWG

Evaluation Board/kit Important Notice

GaN Systems Inc. (GaN Systems) provides the enclosed product(s) under the following AS IS conditions:

This evaluation board/kit being sold or provided by GaN Systems is intended for use for ENGINEERING DEVELOPMENT, DEMONSTRATION, and OR EVALUATION PURPOSES ONLY and is not considered by GaN Systems to be a finished end-product fit for general consumer use. As such, the goods being sold or provided are not intended to be complete in terms of required design-, marketing-, and/or manufacturing-related protective considerations, including but not limited to product safety and environmental measures typically found in end products that incorporate such semiconductor components or circuit boards. This evaluation board/kit does not fall within the scope of the European Union directives regarding electromagnetic compatibility, restricted substances (RoHS), recycling (WEEE), FCC, CE or UL, and therefore may not meet the technical requirements of these directives, or other related regulations.

If this evaluation board/kit does not meet the specifications indicated in the Technical Manual, the board/kit may be returned within 30 days from the date of delivery for a full refund. THE FOREGOING WARRANTY IS THE EXCLUSIVE WARRANTY MADE BY THE SELLER TO BUYER AND IS IN LIEU OF ALL OTHER WARRANTIES, EXPRESSED, IMPLIED, OR STATUTORY, INCLUDING ANY WARRANTY OF MERCHANTABILITY OR FITNESS FOR ANY PARTICULAR PURPOSE. EXCEPT TO THE EXTENT OF THIS INDEMNITY, NEITHER PARTY SHALL BE LIABLE TO THE OTHER FOR ANY INDIRECT, SPECIAL, INCIDENTAL, OR CONSEQUENTIAL DAMAGES. The user assumes all responsibility and liability for proper and safe handling of the goods. Further, the user indemnifies GaN Systems from all claims arising from the handling or use of the goods. Due to the open construction of the product, it is the user's responsibility to take any and all appropriate precautions with regard to electrostatic discharge.

No License is granted under any patent right or other intellectual property right of GaN Systems whatsoever. GaN Systems assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or any other intellectual property rights of any kind.

GaN Systems currently services a variety of customers for products around the world, and therefore this transaction is **not exclusive**.

Please read the Technical Manual and, specifically, the Warnings and Restrictions notice in the Technical Manual prior to handling the product. Persons handling the product(s) must have electronics training and observe good engineering practice standards.

This notice contains important safety information about temperatures and voltages. For further safety concerns, please contact a GaN Systems' application engineer.

www.gansystems.com

Important Notice – Unless expressly approved in writing by an authorized representative of GaN Systems, GaN Systems components are not designed, authorized or warranted for use in lifesaving, life sustaining, military, aircraft, or space applications, nor in products or systems where failure or malfunction may result in personal injury, death, or property or environmental damage. The information given in this document shall not in any event be regarded as a guarantee of performance. GaN Systems hereby disclaims any or all warranties and liabilities of any kind, including but not limited to warranties of non-infringement of intellectual property rights. All other brand and product names are trademarks or registered trademarks of their respective owners. Information provided herein is intended as a guide only and is subject to change without notice. The information contained herein or any use of such information does not grant, explicitly, or implicitly, to any party any patent rights, licenses, or any other intellectual property rights. General Sales and Terms Conditions apply.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

GaN Systems:

GS-EVB-IMS2-065011L-GS GS-EVB-IMS2-66504B-GS GS-EVB-IMS2-LPMB